

CD74HCx4067-Q1 汽车高速 CMOS 逻辑 16 通道模拟多路复用器和多路解复用器

1 特性

- 符合汽车应用要求
- **AEC-Q100 测试指导结果如下：**
 - 器件温度等级 1：-40°C 至 125°C 环境温度范围
 - 器件 HBM ESD 分类等级 H1A
 - 器件 CDM ESD 分类等级 C2
- 宽模拟输入电压范围
- 低导通电阻
 - 70 Ω (典型值) ($V_{CC} = 4.5V$ 时)
- 快速开关和传播速度
- 先断后合开关
 - 6ns (典型值) ($V_{CC} = 4.5V$ 时)
- 扇出 (在温度范围内)
 - 标准输出：10 个 LSTTL 负载
 - 总线驱动器输出：15 个 LSTTL 负载
- 平衡的传播延迟及转换时间
- 与 LSTTL 逻辑 IC 相比，可显著降低功耗
- 工作电压为 4.5V 至 5.5V
- 直接 LSTTL 输入逻辑兼容性： $V_{IL} = 0.8V$ (最大值)， $V_{IH} = 2V$ (最小值)
- CMOS 输入兼容性：在电压为 V_{OL} 、 V_{OH} 时， $I_I \leq 1\mu A$

2 应用

- 汽车
- 模拟开关
- 模拟多路复用器和多路解复用器

3 说明

此 CD74HCx4067-Q1 器件是数字控制的模拟开关，其使用硅栅 CMOS 技术并借助标准 CMOS 集成电路的低功耗特性来实现与 LSTTL 接近的运行速度。

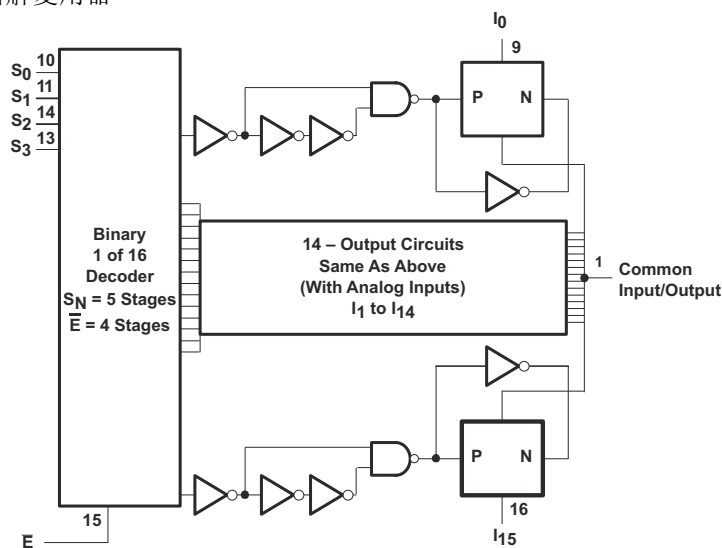
这些模拟多路复用器和多路解复用器可控制模拟电压，该电压可能会在整个电源电压范围内变化。它是双向开关，可将任何模拟输入用作输出，反之亦然。该开关具有低导通电阻和低关断泄漏。此外，此器件具有使能控制，当处于高电平时将禁用所有开关，将所有开关置于关断状态。

封装信息

器件型号	封装 ⁽¹⁾	封装尺寸 ⁽²⁾
CD74HCx4067QM96Q1	DW (SOIC , 24)	15.5mm × 10.3mm
CD74HCx4067QRGYRQ 1	RGY (QFN , 24)	5.5mm × 3.5mm
CD74HCx4067QDGSRQ 1	DGS (VSSOP , 24)	6.1mm × 3mm
CD74HCx4067QPWRQ1	PW (TSSOP , 24)	4.4mm × 7.8mm

(1) 有关更多信息，请参阅 [节 18](#)。

(2) 封装尺寸 (长×宽) 为标称值, 并包括引脚 (如适用)。



逻辑图（正逻辑）

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4 Pin Configuration and Functions

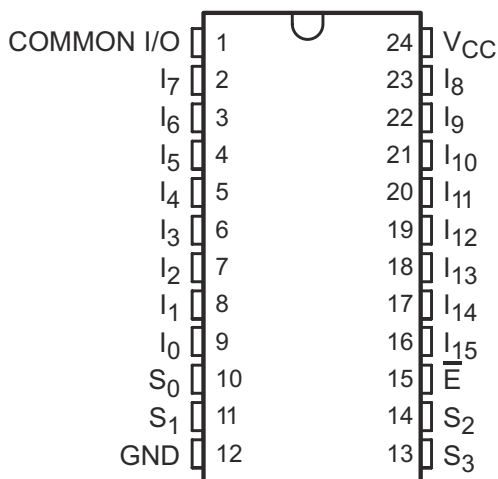


图 4-1. DW Package, 24-Pin SOIC (Top View)

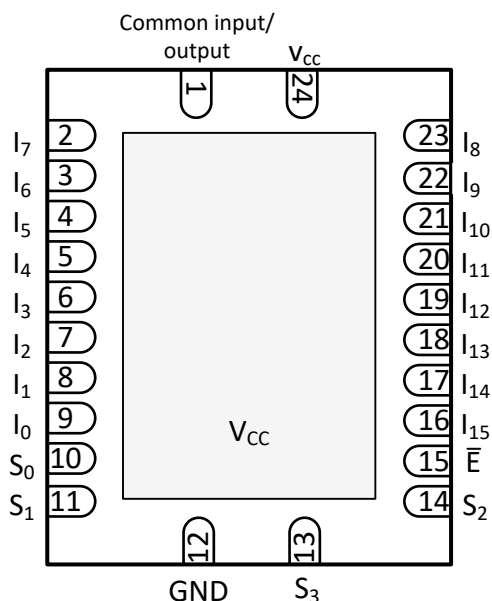


图 4-2. RGY Package, 24-Pin QFN (Top View) (Pad on Bottom)

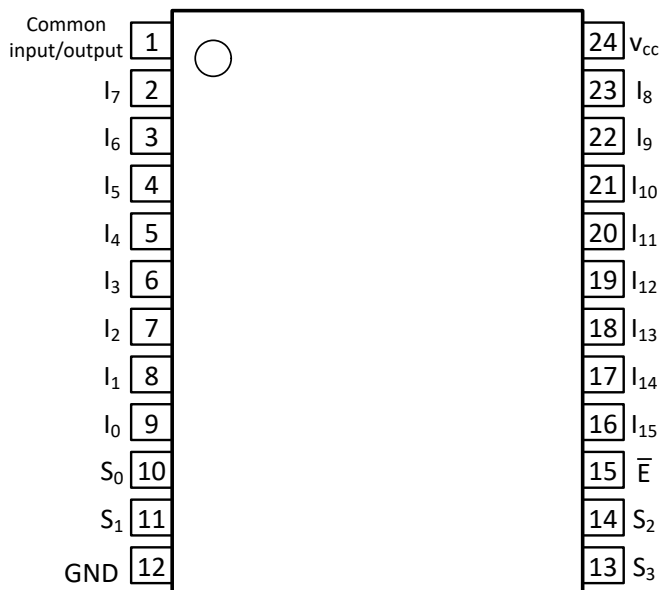


图 4-3. PW Package, 24-Pin TSSOP (Top View)

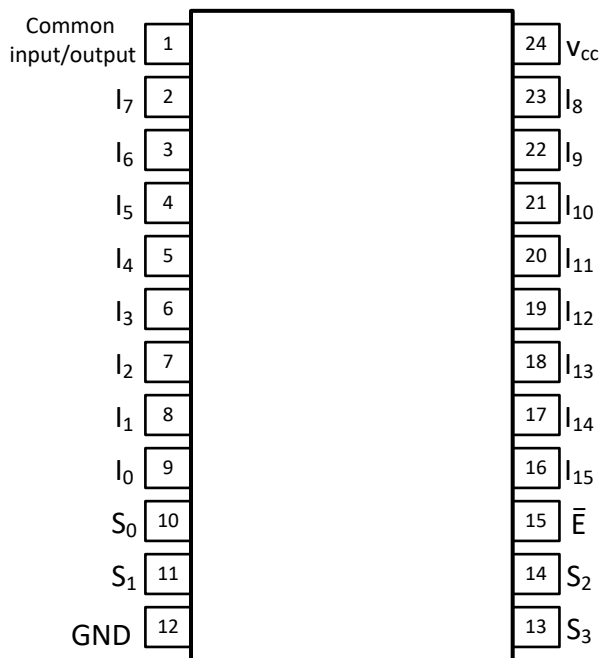


图 4-4. DGS Package, 24-Pin VSSOP (Top View)

PIN		TYPE ⁽¹⁾	DESCRIPTION
NAME	NO.		
COMMON INPUT/OUTPUT	1	IO	Common input or output.
I ₇	2	IO	Switch input/output
I ₆	3	IO	Switch input/output
I ₅	4	IO	Switch input/output
I ₄	5	IO	Switch input/output
I ₃	6	IO	Switch input/output
I ₂	7	IO	Switch input/output
I ₁	8	IO	Switch input/output
I ₀	9	IO	Switch input/output
S ₀	10	I	Select/Address pin
S ₁	11	I	Select/Address pin
GND	12	P	Ground pin
S ₃	13	I	Select/Address pin
S ₂	14	I	Select/Address pin
$\bar{E}$	15	I	Enable for all switches ON/OFF
I ₁₅	16	IO	Switch input/output
I ₁₄	17	IO	Switch input/output
I ₁₃	18	IO	Switch input/output
I ₁₂	19	IO	Switch input/output
I ₁₁	20	IO	Switch input/output
I ₁₀	21	IO	Switch input/output
I ₉	22	IO	Switch input/output
I ₈	23	IO	Switch input/output
V _{CC}	24	P	Power pin
Thermal Pad		-	The thermal pad is not electrically connected and can be floated, grounded or tied to V _{CC}

(1) I = input, O = output. P = power

5 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)^{(1) (2)}

			MIN	MAX	UNIT
V _{CC} HC	DC Supply voltage		-0.5	7	V
V _{CC} HCT			- 0.5	7	V
I _{IK}	DC input diode current	For V _I < -0.5V or V _I > V _{CC} + 0.5V	- 20	20	mA
I _{OK}	DC output diode current	For V _O < -0.5V or V _O > V _{CC} + -0.5V	- 20	20	mA
I _{CC}	DC V _{CC} or ground current		- 50	50	mA
DC Output Source or Sink Current per Output Pin, I _O	For V _O > -0.5V or V _O < V _{CC} + -0.5V		- 25	25	mA
T _{JMAX}	Maximum junction temperature (Plastic Package)			150	°C
T _{stg}	Storage temperature		- 65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltages are with respect to ground, unless otherwise specified.

6 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human body model (HBM), per AEC Q100-002, all pins ⁽¹⁾	400	V
		Charged device model (CDM), per AEC Q100-011, all pins	250	

- (1) AEC Q100-002 indicates that HBM stressing must be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

7 Thermal Information

THERMAL METRIC ⁽¹⁾		CD74HCx4067				UNIT
		DW (SOIC)	RGY (QFN)	DGS (VSSOP)	PW (TSSOP)	
		24 PINS	24 PINS	24 PINS	24 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	84.8	67.1	96.8	97.4	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	57.0	59.2	43.4	45.0	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	59.5	45.4	58.7	62.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	29.0	9.3	3.9	5.20	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	59.0	45.1	58.2	62.1	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	N/A	34.7	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

8 Recommended Operating Conditions

			MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage range (T_A = full package temperature range)	74HC types	2		6	V
V_{CC}	Supply voltage range (T_A = full package temperature range)	74HCT types	4.5		5.5	V
V_{IS}	Analog switch I/O voltage		0		V_{CC}	V
T_A	Ambient temperature	Ambient temperature	– 40		125	°C
t_r, t_f	Input rise and fall times	2V	0		1000	ns
		4.5V	0		500	
		6V	0		400	

9 Electrical Characteristics: HC Devices

Over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS				MIN	TYP	MAX	UNIT
Analog Switch									
		V _{IS} (V)	V _I (V)	V _{CC} (V)	T _A				
High Level Input Voltage	V _{IH}			2	– 40°C to 125°C	1.5		V	
				4.5		3.15			
				6		4.2			
Low Level Input Voltage	V _{IL}			2		0.5		V	
				4.5		1.35			
				6		1.8			
"ON" Resistance IO = 1mA	R _{ON}	V _{CC} or GND	V _{CC} or GND	4.5	25°C	70	160	Ω	
					– 40°C to 125°C	200			
				6	25°C	60	140		
					– 40°C to 125°C	175			
		V _{CC} to GND	V _{CC} to GND	4.5	25°C	90	180		
					– 40°C to 125°C	225			
				6	25°C	80	160		
					– 40°C to 125°C	200			
"ON" Resistance Between Any Two Switches	Δ R _{ON}			4.5	25°C	10	Ω		
				6	25°C	8.5			
Off-Switch Leakage Current	I _Z	E = V _{CC}	V _{CC} or GND	6	25°C	±0.8		μA	
					– 40°C to 125°C	±8			
Input Leakage Current (Any Control)	I _{IL}		V _{CC} or GND ⁽¹⁾	6	25°C	±0.1		μA	
					– 40°C to 125°C	±1			
Quiescent Device Current	I _{CC}		V _{CC} or GND	6	25°C	8		μA	
					– 40°C to 125°C	160			

(1) Any voltage between V_{CC} and GND.

10 Electrical Characteristics: HCT Devices

Over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS				MIN	TYP	MAX	UNIT
Analog Switch									
		V _{IS} (V)	V _I (V)	V _{CC} (V)	T _A				
High Level Input Voltage		V _{IH}		4.5	25°C	2			V
Low Level Input Voltage		V _{IL}			– 40°C to 125°C	0.8			V
"ON" Resistance IO = 1mA		R _{ON}	V _{CC} or GND	V _{CC} or GND	4.5	25°C	70	160	Ω
						– 40°C to 125°C	200		
			VCC to GND	VCC to GND		25°C	90	180	
						– 40°C to 125°C	225		
"ON" Resistance Between Any Two Switches		Δ R _{ON}		4.5	25°C	10			Ω
Off-Switch Leakage Current		I _Z	E = V _{CC}	V _{CC} or GND	5.5	25°C	±0.8		μA
						– 40°C to 125°C	±8		
Input Leakage Current (Any Control)		I _{IL}		V _{CC} or GND	5.5	25°C	±0.1		μA
						– 40°C to 125°C	±1		
Quiescent Device Current		I _{CC}		V _{CC} or GND	5.5	25°C	8		μA
						– 40°C to 125°C	80		
Additional Quiescent Device Current Per Input Pin: 1 Unit Load		Δ I _{CC} (1)		V _{CC} - 2.1	4.5 to 5.5	25°C	100	360	μA
						– 40°C to 125°C	450		
C _I	Control inputs					25°C	10		pF
						– 55°C to 85°C	10		
						– 55°C to 125°C	10		

(1) For dual-supply systems theoretical worst case ($V_I = 2.4\text{V}$, $V_{CC} = 5.5\text{V}$) specification is 1.8mA

11 Switching Characteristics HC

over operating free-air temperature range (unless otherwise noted)

Parameter		Test Conditions		C _L (pF)	MIN	NOM	MAX	UNIT
	FROM (INPUT) TO (OUTPUT)	V _{CC} (V)	T _A					
t _{pd}	I _n TO Common I/O	2	25°C	50			75	ns
			-40°C to 125°C				110	
		4.5	25°C				15	ns
			-40°C to 125°C				22	
		6	25°C				13	ns
			-40°C to 125°C				19	
		5	25°C	15		6		ns
t _{en}	E TO Common I/O	2	25°C	50			275	ns
			-40°C to 125°C				415	
		4.5	25°C				55	ns
			-40°C to 125°C				83	
		6	25°C				47	ns
			-40°C to 125°C				71	
		5	25°C	15		23		ns
t _{en}	S _n TO Common I/O	2	25°C	50			300	ns
			-40°C to 125°C				450	
		4.5	25°C				60	ns
			-40°C to 125°C				90	
		6	25°C				51	ns
			-40°C to 125°C				76	
		5	25°C	15		25		ns
t _{dis}	E TO Common I/O	2	25°C	50			275	ns
			-40°C to 125°C				415	
		4.5	25°C				55	ns
			-40°C to 125°C				83	
		6	25°C				47	ns
			-40°C to 125°C				71	
		5	25°C	15		23		ns
t _{dis}	S _n TO Common I/O	2	25°C	50			290	ns
			-40°C to 125°C				435	
		4.5	25°C				58	ns
			-40°C to 125°C				87	
		6	25°C				49	ns
			-40°C to 125°C				74	
		5	25°C	15		21		ns

over operating free-air temperature range (unless otherwise noted)

Parameter		Test Conditions		C _L (pF)	MIN	NOM	MAX	UNIT
C _{PD} Power dissipation capacitance(1)	C _{PD}	5	25°C			93		pF

12 Switching Characteristics HCT

over operating free-air temperature range (unless otherwise noted)

Parameter		Test Conditions		C _L (pF)	MIN	NOM	MAX	UNIT
	FROM (INPUT) TO (OUTPUT)	V _{CC} (V)	T _A					
t _{pd}	I _n TO Common I/O	5	25°C	15		6		ns
		4.5	25°C	50			15	
			-40°C to 125°C				19	
t _{en}	E TO Common I/O	5	25°C	15		25		ns
		4.5	25°C	50			60	
			-40°C to 125°C				75	
t _{en}	S _n TO Common I/O	5	25°C	15		25		ns
		4.5	25°C	50			60	
			-40°C to 125°C				75	
t _{dis}	E TO Common I/O	5	25°C	15		23		ns
		4.5	25°C	50			55	
			-40°C to 125°C				69	
t _{dis}	S _n TO Common I/O	5	25°C	15		21		ns
		4.5	25°C	50			58	
			-40°C to 125°C				73	
C _{PD} Power dissipation capacitance(1)	C _{PD}	5	25°C			96		pF

13 Analog Channel Specifications

over operating free-air temperature range (unless otherwise noted)

Parameter	Test Conditions		V _{CC} (V)	HC	HCT	UNIT
Switch Frequency Response Bandwidth at -3dB			4.5	89	89	MHz
Total Harmonic Distortion	1kHz, V _{IS} = 4V _{PP}		4.5	0.051	0.051	%
Switch "OFF" signal feedthrough			4.5	-75	-75	dB
C _S Switch input capacitance				5	5	pF
C _{COM} Common Capacitance				50	50	pF

14 Parameter Measurement Information

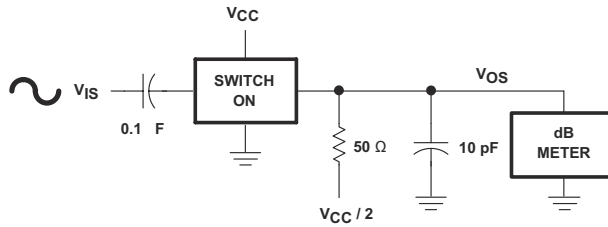


图 14-1. Frequency-Response Test Circuit

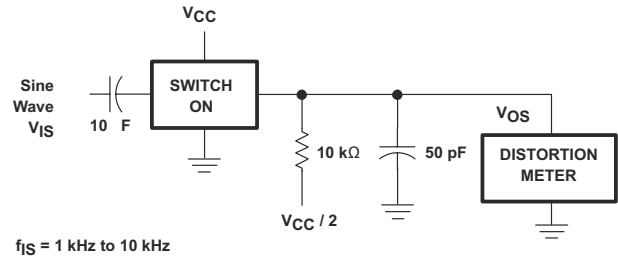


图 14-2. Sine-Wave Distortion Test Circuit

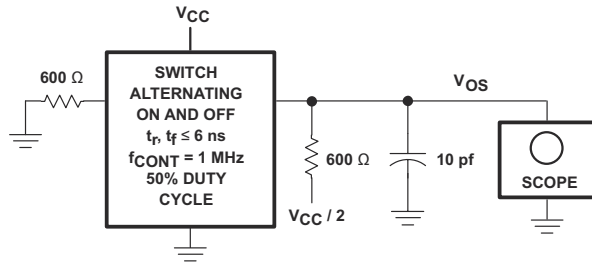


图 14-3. Control-to-Switch Feedthrough Noise Test Circuit

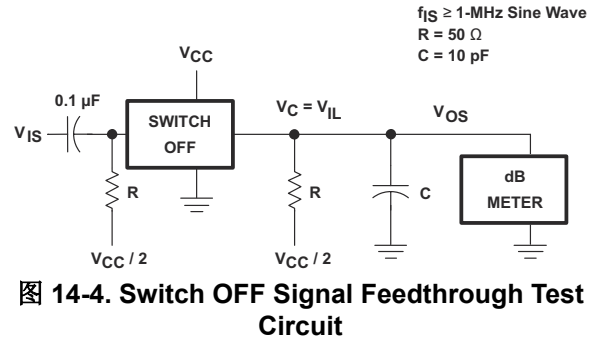
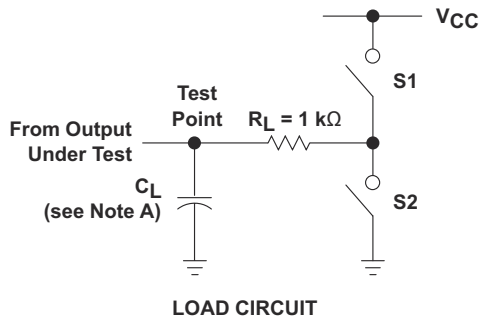
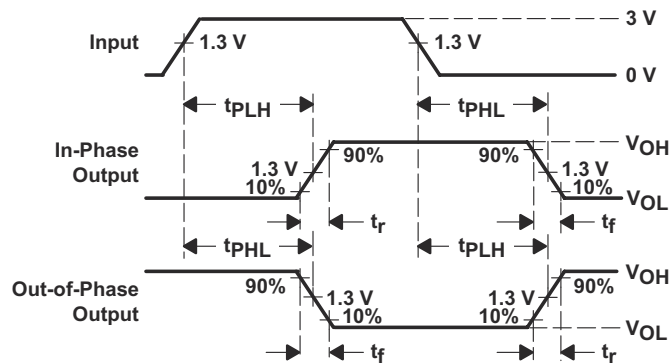


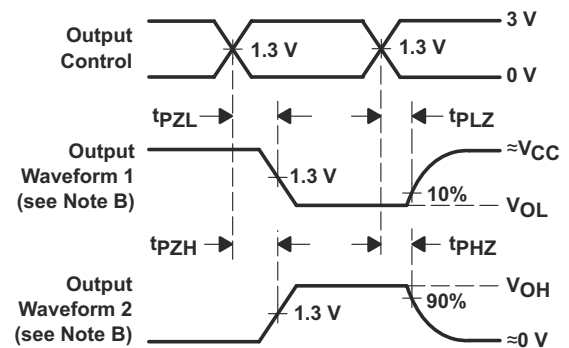
图 14-4. Switch OFF Signal Feedthrough Test Circuit



PARAMETER	S1	S2
t_{en}	t_{PZH} Open	Closed
	t_{PZL} Closed	Open
t_{dis}	t_{PHZ} Open	Closed
	t_{PLZ} Closed	Open
t_{pd}	Open	Open



VOLTAGE WAVEFORMS
PROPAGATION DELAY AND OUTPUT TRANSITION TIMES



VOLTAGE WAVEFORMS
OUTPUT ENABLE AND DISABLE TIMES

- NOTES:
- A. C_L includes probe and test-fixture capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1\text{ MHz}$, $Z_O = 50\ \Omega$, $t_r = 6\text{ ns}$, $t_f = 6\text{ ns}$.
 - D. For clock inputs, f_{max} is measured with the input duty cycle at 50%.
 - E. The outputs are measured one at a time, with one input transition per measurement.
 - F. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - G. t_{PZL} and t_{PZH} are the same as t_{en} .
 - H. t_{PLH} and t_{PHL} are the same as t_{pd} .

图 14-5. Load Circuit and Voltage Waveforms

15 Detailed Description

15.1 Functional Block Diagram

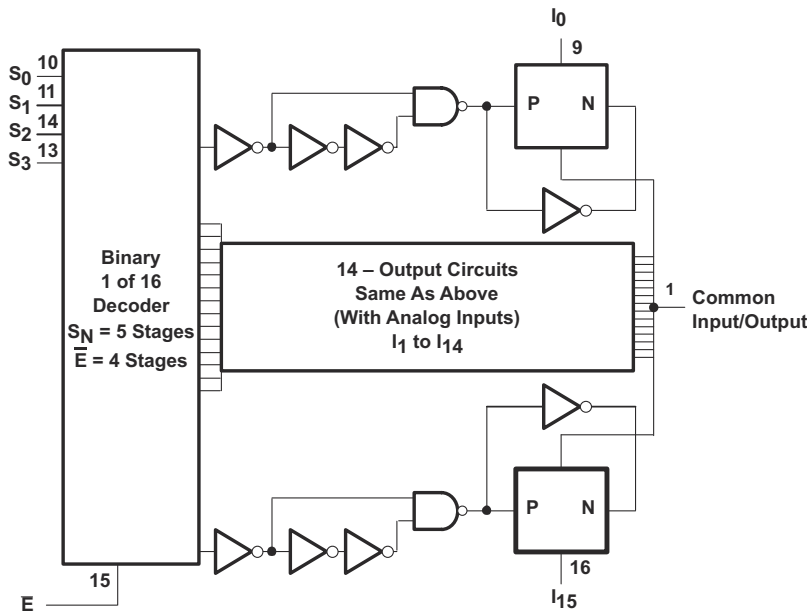


图 15-1. Logic Diagram (Positive Logic)

15.2 Device Functional Modes

表 15-1. Function Table ⁽¹⁾

S0	S1	S2	S3	E	SELECTED CHANNEL
X	X	X	X	H	None
L	L	L	L	L	0
H	L	L	L	L	1
L	H	L	L	L	2
H	H	L	L	L	3
L	L	H	L	L	4
H	L	H	L	L	5
L	H	H	L	L	6
H	H	H	L	L	7
L	L	L	H	L	8
H	L	L	H	L	9
L	H	L	H	L	10
H	H	L	H	L	11
L	L	H	H	L	12
H	L	H	H	L	13
L	H	H	H	L	14
H	H	H	H	L	15

(1) H = High level
L = Low level
X = Don't Care

16 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

16.1 接收文档更新通知

要接收文档更新通知，请导航至 ti.com 上的器件产品文件夹。点击 [通知](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

16.2 支持资源

[TI E2E™ 中文支持论坛](#) 是工程师的重要参考资料，可直接从专家处获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题，获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的 [使用条款](#)。

16.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.
所有商标均为其各自所有者的财产。

16.4 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

16.5 术语表

[TI 术语表](#) 本术语表列出并解释了术语、首字母缩略词和定义。

17 Revision History

注：以前版本的页码可能与当前版本的页码不同

Changes from Revision C (February 2025) to Revision D (April 2025)	Page
• 添加了 CD74HC4067-Q1.....	1

Changes from Revision B (April 2008) to Revision C (February 2025)	Page
• 更新了整个文档中的表格、图和交叉参考的编号格式.....	1
• Updated Thermal parameters for DW package.....	6
• Added RGY, DGS, and PW packages.....	6
• Added HC Electrical characteristics.....	7
• Added HC Switching characteristics.....	9

Changes from Revision A (April 2008) to Revision B (August 2012)	Page
• 通篇将 H2 更改为 H1A 并将 C3B 更改为 C2.....	1
• 向“特性”添加了 AEC-Q100 信息.....	1
• 从“特性”中删除了以下内容：宽工作温度范围：-40°C 至 85°C.....	1
• 添加的应用.....	1
• 将订购信息表中的 SOIC-M 封装信息替换为 DW-SOIC-M 封装的新行.....	1

18 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CD74HC4067QDGSRQ1	Active	Production	VSSOP (DGS) 24	5000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	H4067Q
CD74HC4067QPWRQ1	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4067Q
CD74HC4067QPWRQ1.A	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC4067Q
CD74HC4067QRGYRQ1	Active	Production	VQFN (RGY) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	HC4067Q
CD74HC4067QRGYRQ1.A	Active	Production	VQFN (RGY) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	HC4067Q
CD74HCT4067QDGSRQ1	Active	Production	VSSOP (DGS) 24	5000 LARGE T&R	-	Call TI	Level-1-260C-UNLIM	-40 to 125	T4067Q
CD74HCT4067QM96Q1	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4067I
CD74HCT4067QM96Q1.A	Active	Production	SOIC (DW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4067I
CD74HCT4067QPWRQ1	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4067Q
CD74HCT4067QPWRQ1.A	Active	Production	TSSOP (PW) 24	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HCT4067Q
CD74HCT4067QRGYRQ1	Active	Production	VQFN (RGY) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	HCT4067Q
CD74HCT4067QRGYRQ1.A	Active	Production	VQFN (RGY) 24	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	HCT4067Q
D24067IM96G4Q1	Obsolete	Production	SOIC (DW) 24	-	-	Call TI	Call TI	-40 to 85	HCT4067I

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF CD74HC4067-Q1, CD74HCT4067-Q1 :

- Catalog : [CD74HC4067](#), [CD74HCT4067](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product

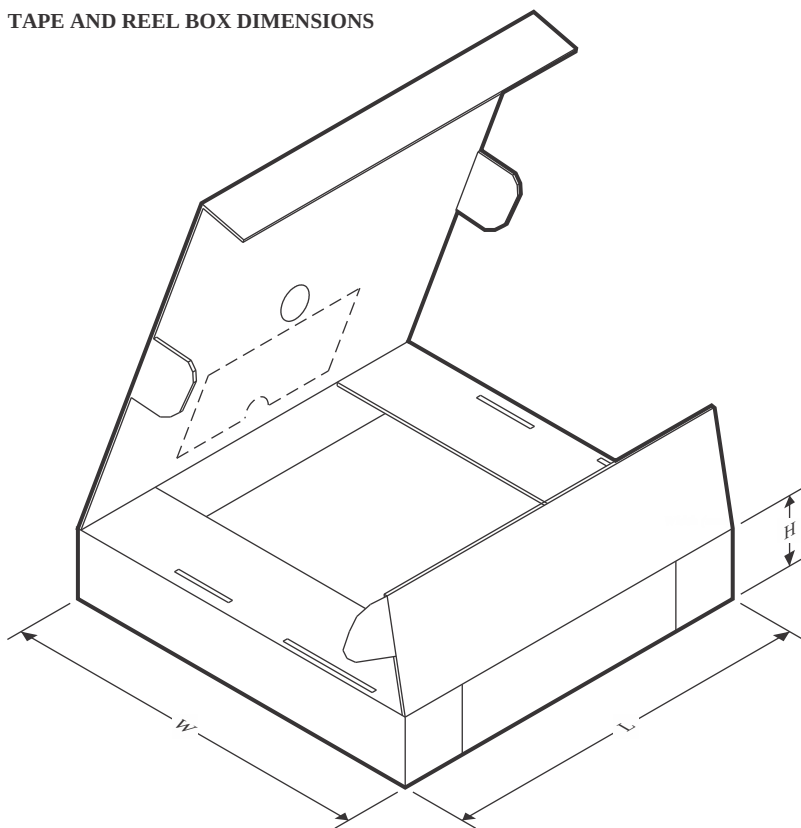
TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC4067QDGSRQ1	VSSOP	DGS	24	5000	330.0	16.4	5.44	6.4	1.45	8.0	16.0	Q1
CD74HC4067QPWRQ1	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
CD74HC4067QRGYRQ1	VQFN	RGY	24	3000	330.0	12.4	3.8	5.8	1.2	8.0	12.0	Q1
CD74HCT4067QDGSRQ1	VSSOP	DGS	24	5000	330.0	16.4	5.44	6.4	1.45	8.0	16.0	Q1
CD74HCT4067QM96Q1	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
CD74HCT4067QPWRQ1	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
CD74HCT4067QRGYRQ1	VQFN	RGY	24	3000	330.0	12.4	3.8	5.8	1.2	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC4067QDGSRQ1	VSSOP	DGS	24	5000	353.0	353.0	32.0
CD74HC4067QPWRQ1	TSSOP	PW	24	2000	353.0	353.0	32.0
CD74HC4067QRGYRQ1	VQFN	RGY	24	3000	367.0	367.0	35.0
CD74HCT4067QDGSRQ1	VSSOP	DGS	24	5000	353.0	353.0	32.0
CD74HCT4067QM96Q1	SOIC	DW	24	2000	350.0	350.0	43.0
CD74HCT4067QPWRQ1	TSSOP	PW	24	2000	353.0	353.0	32.0
CD74HCT4067QRGYRQ1	VQFN	RGY	24	3000	367.0	367.0	35.0



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



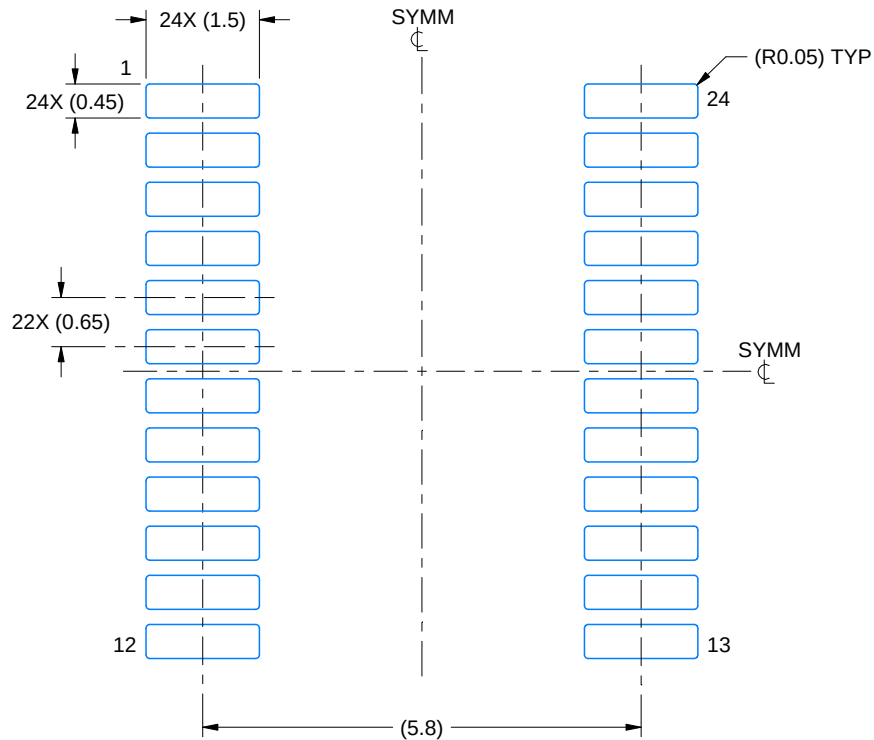
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

EXAMPLE BOARD LAYOUT

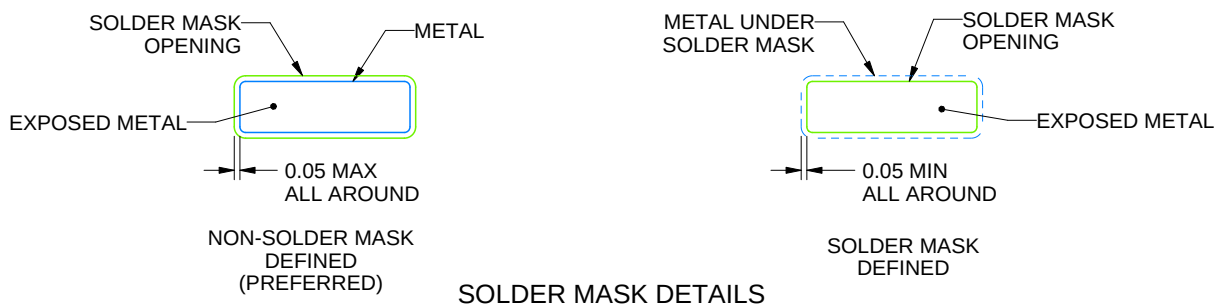
PW0024A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



SOLDER MASK DETAILS

4220208/A 02/2017

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

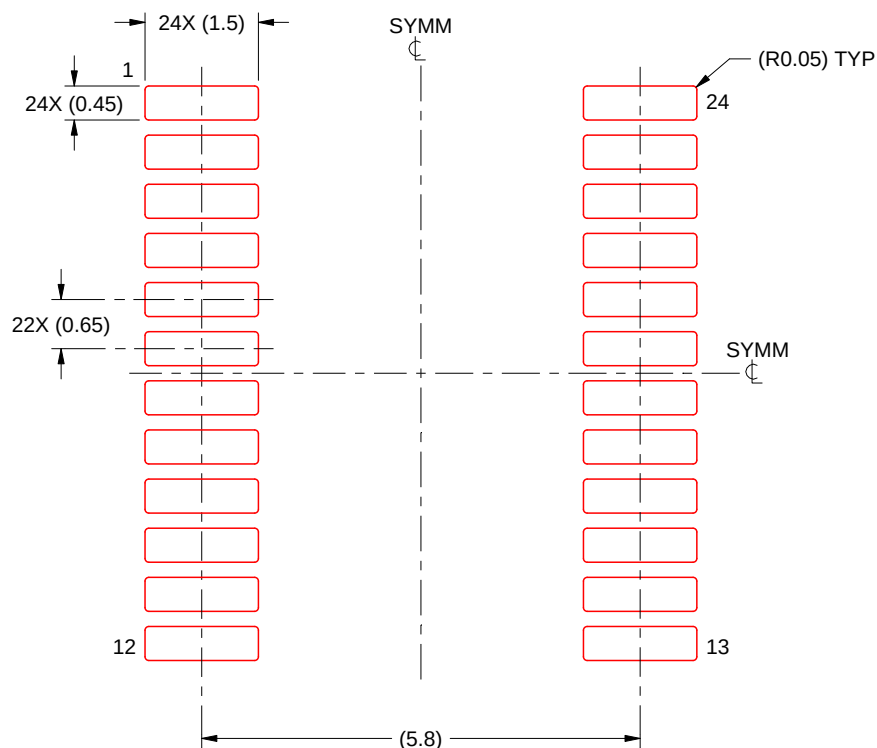
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

PW0024A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

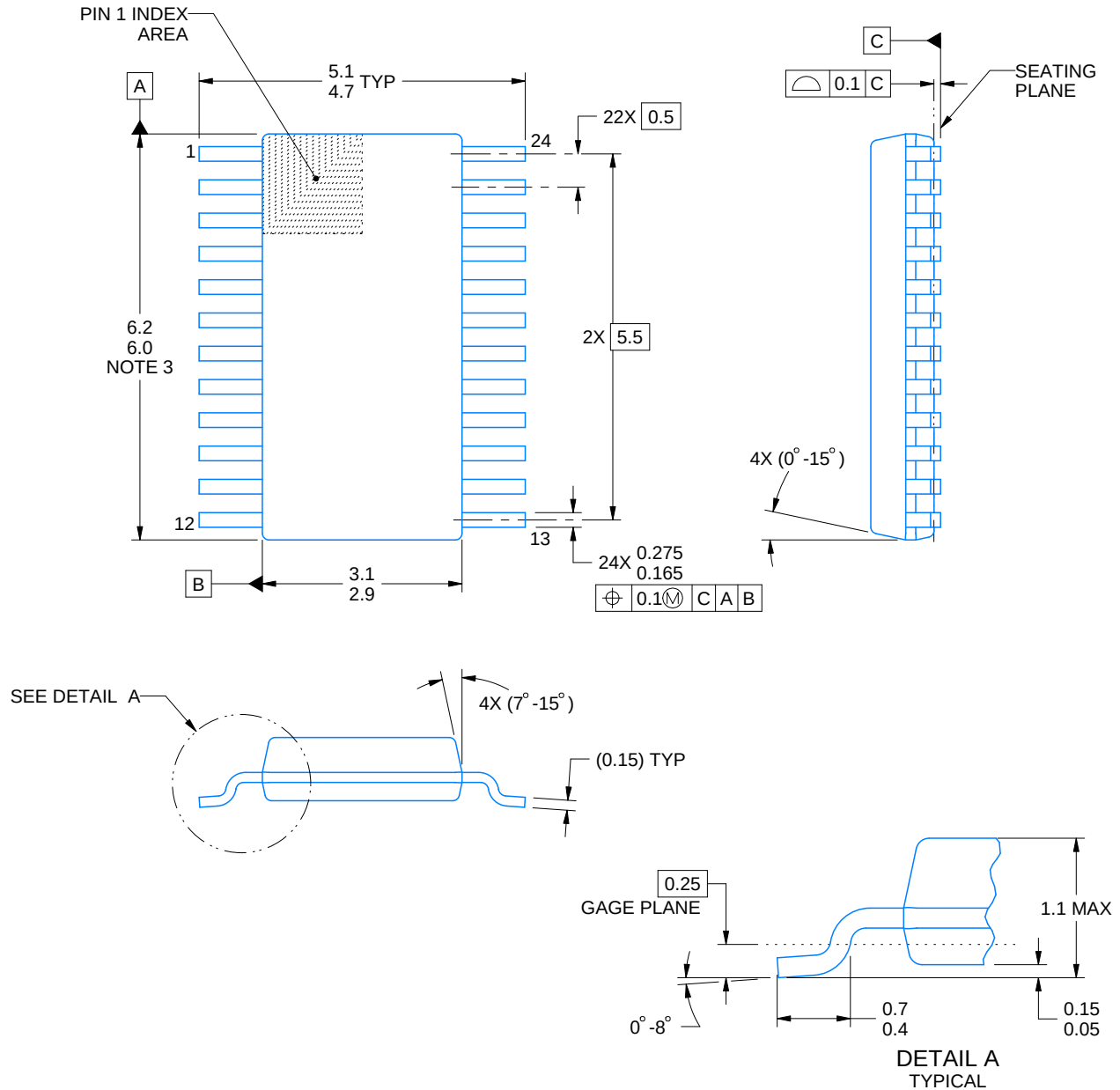


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220208/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



4226366/A 10/2020

NOTES:

PowerPAD is a trademark of Texas Instruments.

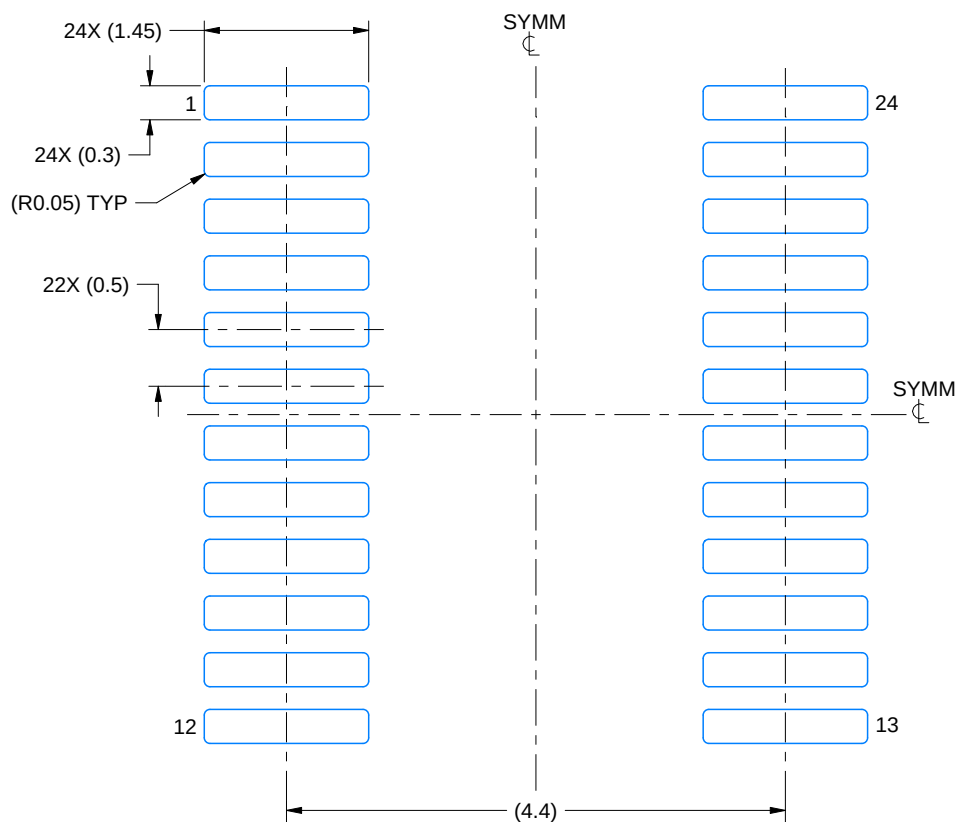
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. No JEDEC registration as of September 2020.
5. Features may differ or may not be present.

EXAMPLE BOARD LAYOUT

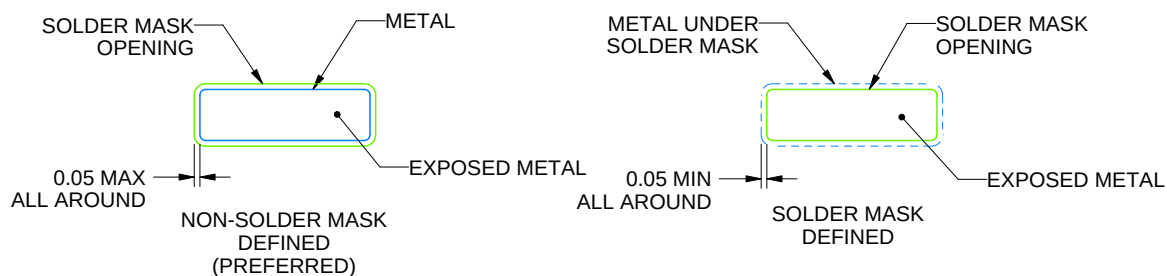
DGS0024A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
SCALE: 15X



SOLDER MASK DETAILS

4226366/A 10/2020

NOTES: (continued)

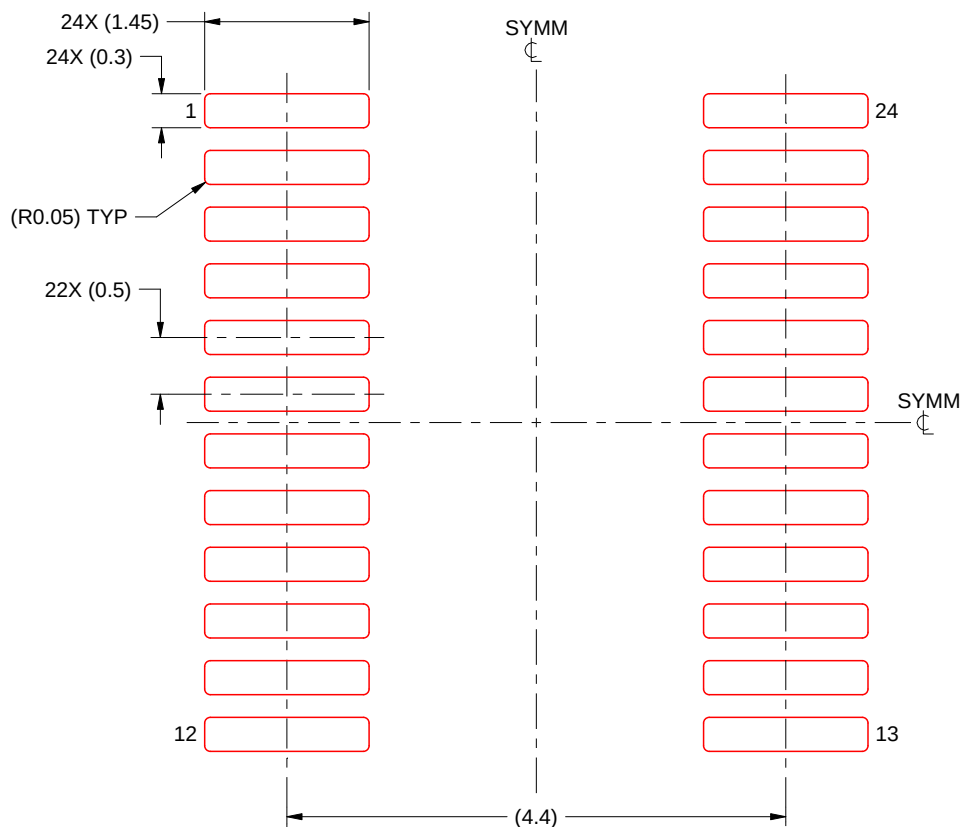
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
9. Size of metal pad may vary due to creepage requirement.
10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

DGS0024A

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 15X

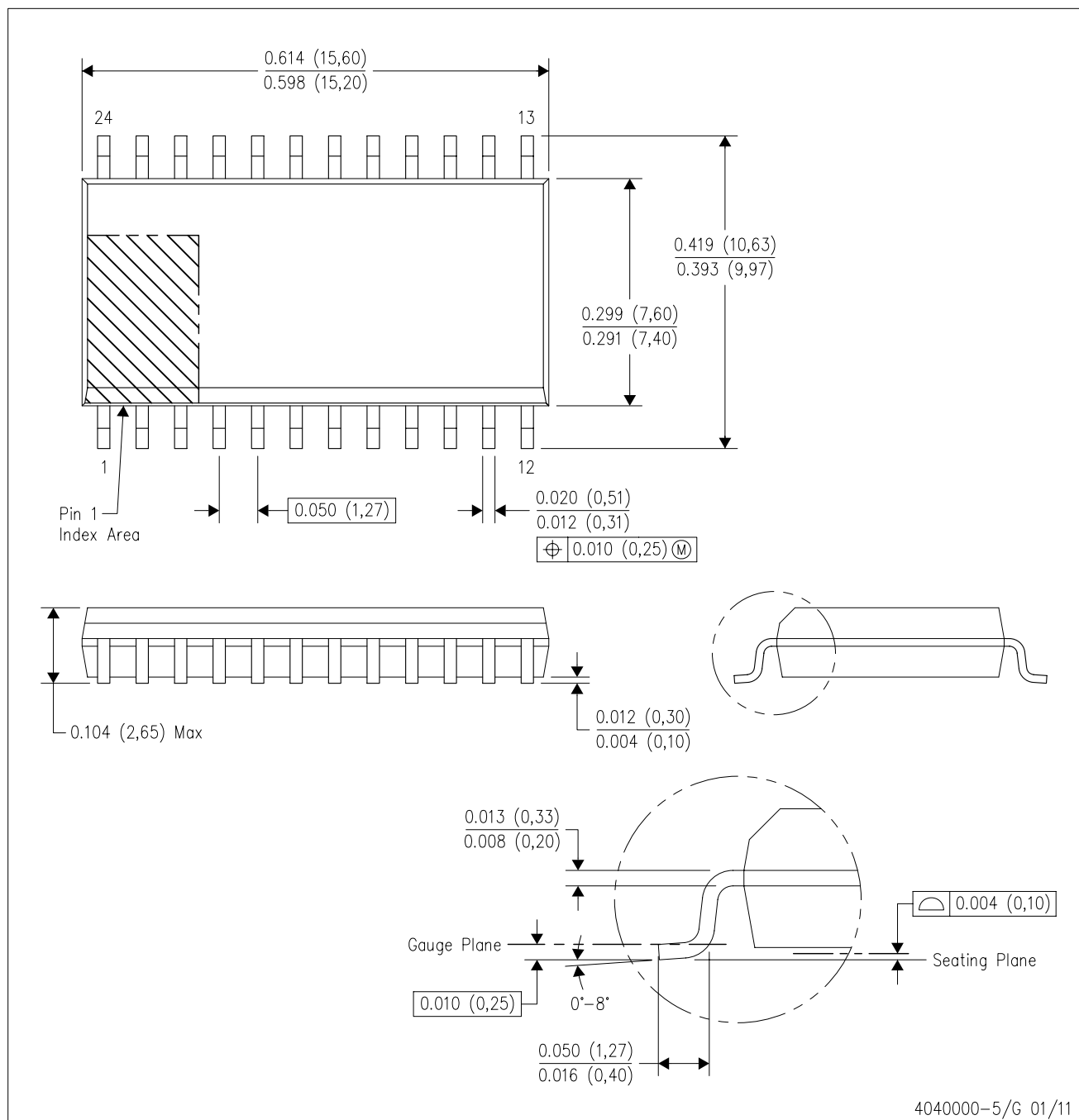
4226366/A 10/2020

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



- NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
D. Falls within JEDEC MS-013 variation AD.

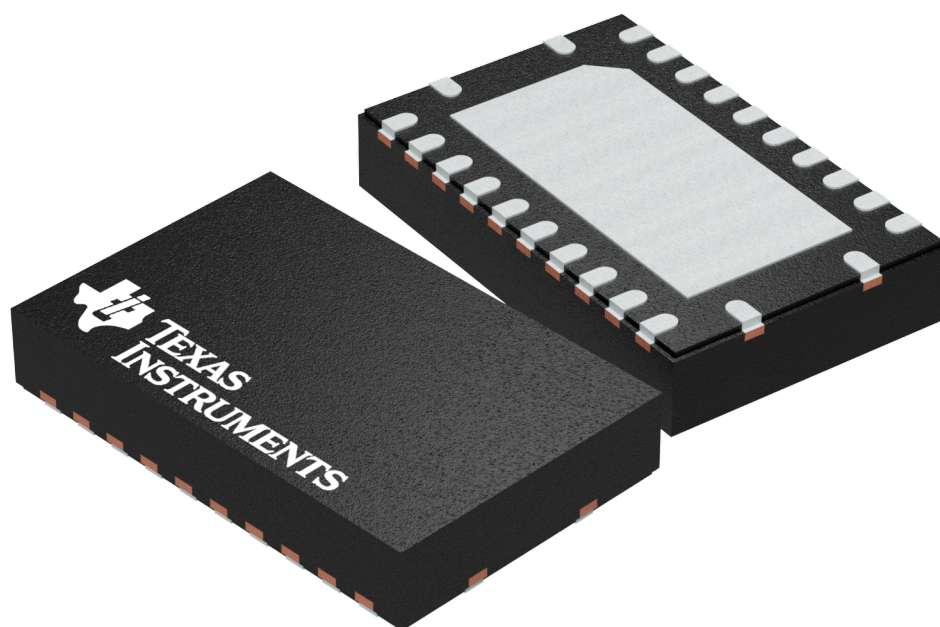
GENERIC PACKAGE VIEW

RGY 24

VQFN - 1 mm max height

5.5 x 3.5 mm, 0.5 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4203539-5/J

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